

Notice of References Cited	Application/Control No. 09/720,347	Applicant(s)/Patent Under Reexamination IVANOV ET AL.	
	Examiner Lynne Edmondson	Art Unit 1725	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,342,496	08-1994	Stellrecht, David E.	204/298.12
*	B	US-5,269,899	12-1993	Fan, Jia S.	204/298.09
*	C	US-5,836,506	11-1998	Hunt et al.	228/172
*	D	US-5,009,765	04-1991	Qamar et al.	204/298.12
*	E	US-5,230,459	07-1993	Mueller et al.	228/164
*	F	US-6,071,389	06-2000	Zhang, Hao	204/298.12
*	G	US-6,199,259	03-2001	Demaray et al.	29/458
*	H	US-5,143,590	09-1992	Strothers et al.	204/298.12
*	I	US-5,215,639	06-1993	Boys, Donald R.	204/192.12
*	J	US-6,451,185	09-2002	Beier et al.	204/298.12
*	K	US-6,074,279	06-2000	Yoshimura et al.	451/37
*	L	US-6,164,519	12-2000	Gilman et al.	228/107
*	M	US-6,113,761	09-2000	Kardokus et al.	204/298.13

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP-043362-A	02-1990	Japan	Ogata et al.	
*	O	JP-04-128371-A	04-1992	Japan	Arima	
*	P	JP-59-232270-A	12-1984	Japan	Masuoka et al.	
*	Q	JP-06-065733-A	03-1994	Japan	Dunlop et al.	
*	R	JP-02-043362-A	02-1990	Japan	Ogata et al.	
*	S	JP-04-168267-A	06-1992	Japan	Taniguchi et al.	
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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